

## 650V 75A Insulated Gate Bipolar Transistor AKB65A075WHS

### Description:

Gen 3 IGBT with soft, fast recovery full current rated anti-parallel Emitter Controlled diode, providing ultra-low conduction loss. They are designed for applications such as UPS, inverters, etc.

### Features:

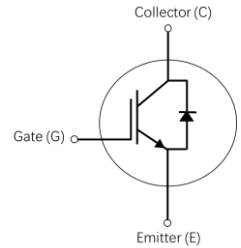
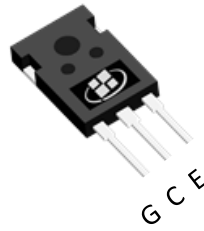
- Easy paralleling capability due to positive temperature coefficient in  $V_{CESAT}$
- Low EMI
- Low Gate Charge
- Very soft, fast recovery full current anti-parallel diode
- Maximum junction temperature  $T_{VJmax}=175^{\circ}C$
- RoHS compliant <sup>(Note 1)</sup>
- Halogen-free <sup>(Note 1)</sup>

### Applications:

- Industrial UPS
- Charger
- Energy Storage
- Three-Phase Solar String Inverter

### Key Performance Parameters:

Parameter	Value	Unit
$V_{CE}$	650	V
$V_{CESAT}, T_{VJ} = 25^{\circ}C$	1.4	V
$I_C$	75	A



### Ordering Information:

Ordering Code	Package Type	Marking Code	Form	Packing
AKB65A075WHS	TO247-3L	B65A075WHS	Tube	300 per box

**Maximum Ratings** ( $T_{VJ} = 25^{\circ}\text{C}$  unless otherwise noted)

Symbol	Parameter	Value	Units
$V_{CE}$	Collector-Emitter Voltage	650	V
$I_C$	Collector Current - Continuous ( $T_C = 25^{\circ}\text{C}$ ) <sup>(Note 1)</sup>	80	A
	Collector Current - Continuous ( $T_C = 100^{\circ}\text{C}$ )	80	A
$I_{CM}$	Collector Current - Pulsed <sup>(Note 2)</sup>	300	A
$I_F$	Diode Forward Current, Limited by $T_{VJmax}$ ( $T_C = 25^{\circ}\text{C}$ )	80	A
	Diode Forward Current, Limited by $T_{VJmax}$ ( $T_C = 100^{\circ}\text{C}$ )	80	A
$I_{FM}$	Diode Pulsed Current, - Pulsed <sup>(Note 2)</sup>	300	A
$V_{GE}$	Gate-Emitter Voltage	$\pm 20$	V
	Transient Gate-Emitter Voltage ( $t_p \leq 10\mu\text{s}$ , $D < 0.010$ )	$\pm 30$	
$P_D$	Power Dissipation ( $T_C = 25^{\circ}\text{C}$ )	277	W
	Power Dissipation ( $T_C = 100^{\circ}\text{C}$ )	138	W
$T_{VJ}$	Operating Junction Temperature Range	-40 to +175	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature Range	-55 to +150	$^{\circ}\text{C}$

**Thermal Characteristics**

Symbol	Parameter	Value	Units
$R_{\theta JC}$	IGBT Thermal Resistance, Junction-to-Case, Steady-State	0.45	$^{\circ}\text{C}/\text{W}$
$R_{\theta JC}$	Diode Thermal Resistance, Junction-to-Case, Steady-State	0.54	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient Steady State	40	$^{\circ}\text{C}/\text{W}$

**Notes:**

1. The max collector current rating is package limited
2. Repetitive rating: pulse width limited by maximum junction temperature

**Electrical Characteristics** ( $T_{VJ} = 25^{\circ}\text{C}$  unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>Static Characteristics</b>						
$V_{(BR)CES}$	Collector-Emitter Breakdown Voltage	$V_{GE} = 0\text{ V}, I_C = 0.2\text{ mA}$	650			V
$V_{CESAT}$	Collector-Emitter Saturation Voltage	$V_{GE} = 15\text{ V}, I_C = 75\text{ A}$		1.40	1.75	V
		$V_{GE} = 15\text{ V}, I_C = 75\text{ A}, T_{VJ} = 125^{\circ}\text{C}$		1.58		
		$V_{GE} = 15\text{ V}, I_C = 75\text{ A}, T_{VJ} = 175^{\circ}\text{C}$		1.68		
$V_F$	Diode Forward Voltage	$V_{GE} = 0\text{ V}, I_F = 75\text{ A}$		1.50	1.90	V
		$V_{GE} = 0\text{ V}, I_F = 75\text{ A}, T_{VJ} = 125^{\circ}\text{C}$		1.63		
		$V_{GE} = 0\text{ V}, I_F = 75\text{ A}, T_{VJ} = 175^{\circ}\text{C}$		1.60		
$V_{GE(TH)}$	Gate-Emitter Threshold Voltage	$V_{CE} = V_{GE}, I_C = 0.75\text{ mA}$	3.2	4.0	4.8	V
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{CE} = 650\text{ V}, V_{GE} = 0\text{ V}$			50	$\mu\text{A}$
		$V_{CE} = 650\text{ V}, V_{GE} = 0\text{ V}, T_{VJ} = 175^{\circ}\text{C}$		3000		
$I_{GES}$	Gate-Emitter Leakage Current	$V_{GE} = \pm 20\text{ V}, V_{CE} = 0\text{ V}$			$\pm 100$	nA
$G_{FS}$	Transconductance	$V_{CE} = 20\text{ V}, I_C = 75\text{ A}$		75		S
<b>Dynamic Characteristics</b>						
$C_{ies}$	Input Capacitance	$V_{CE} = 25\text{ V}, V_{GE} = 0\text{ V}, F = 1\text{ MHz}$		4590		pF
$C_{oes}$	Output Capacitance			215		pF
$C_{res}$	Reverse Transfer Capacitance			23		pF
$Q_G$	Total Gate Charge	$V_{CC} = 520\text{ V}, I_C = 75\text{ A}, V_{GE} = 15\text{ V}$		177		nC
$Q_{GE}$	Gate-Emitter Charge			27		nC
$Q_{GC}$	Gate-Collector Charge			58		nC
$L_E$	Internal Emitter Inductance			13		nH
<b>Switching Characteristics, Inductive Load (<math>T_{VJ} = 25^{\circ}\text{C}</math>)</b>						
$T_{D(ON)}$	Turn On Delay Time	$V_{CC} = 400\text{ V}, I_C = 75\text{ A}, V_{GE} = 15\text{ V}, R_{Gon} = 18\ \Omega, R_{Goff} = 5.6\ \Omega$		55		ns
$T_R$	Rise Time			52		ns
$T_{D(OFF)}$	Turn Off Delay Time			158		ns
$T_F$	Fall Time			15		ns
$E_{ON}$	Turn On Energy			2.60		mJ
$E_{OFF}$	Turn Off Energy			0.88		mJ
$E_{TOTAL}$	Total Switching Energy			3.48		mJ

$T_{D(ON)}$	Turn On Delay Time	$V_{CC} = 400\text{ V}$ $I_C = 37.5\text{ A}$ $V_{GE} = 15\text{ V}$ $R_{Gon} = 18\ \Omega$ $R_{Goff} = 5.6\ \Omega$		53		ns
$T_R$	Rise Time			30		ns
$T_{D(OFF)}$	Turn Off Delay Time			184		ns
$T_F$	Fall Time			12		ns
$E_{ON}$	Turn On Energy			1.11		mJ
$E_{OFF}$	Turn Off Energy			0.44		mJ
$E_{TOTAL}$	Total Switching Energy			1.55		mJ

**Diode Characteristics (  $T_{VJ} = 25^\circ\text{C}$  )**

$T_{RR}$	Reverse Recovery Time	$V_R = 400\text{ V}, I_F = 75\text{ A},$ $di/dt = 1300\text{ A}/\mu\text{s}$		115		ns
$Q_{RR}$	Reverse Recovery Charge			3.3		$\mu\text{C}$
$I_{RRM}$	Peak Reverse Recovery Current			38		A
$d_{irr}/dt$	Diode Peak Rate of Fall of Reverse Recovery Current			1525		$\text{A}/\mu\text{s}$

$T_{RR}$	Reverse Recovery Time	$V_R = 400\text{ V}, I_F = 37.5\text{ A},$ $di/dt = 1200\text{ A}/\mu\text{s}$		158		ns
$Q_{RR}$	Reverse Recovery Charge			1.6		$\mu\text{C}$
$I_{RRM}$	Peak Reverse Recovery Current			36		A
$d_{irr}/dt$	Diode Peak Rate of Fall of Reverse Recovery Current			1123		$\text{A}/\mu\text{s}$

**Switching Characteristics, Inductive Load (  $T_{VJ} = 150^\circ\text{C}$  )**

$T_{D(ON)}$	Turn On Delay Time	$V_{CC} = 400\text{ V}$ $I_C = 75\text{ A}$ $V_{GE} = 15\text{ V}$ $R_{Gon} = 18\ \Omega$ $R_{Goff} = 5.6\ \Omega$		60		ns
$T_R$	Rise Time			51		ns
$T_{D(OFF)}$	Turn Off Delay Time			183		ns
$T_F$	Fall Time			39		ns
$E_{ON}$	Turn On Energy			3.31		mJ
$E_{OFF}$	Turn Off Energy			1.45		mJ
$E_{TOTAL}$	Total Switching Energy			4.76		mJ

$T_{D(ON)}$	Turn On Delay Time	$V_{CC} = 400\text{ V}$ $I_C = 37.5\text{ A}$ $V_{GE} = 15\text{ V}$ $R_{Gon} = 18\ \Omega$ $R_{Goff} = 5.6\ \Omega$		50		ns
$T_R$	Rise Time			33		ns
$T_{D(OFF)}$	Turn Off Delay Time			228		ns
$T_F$	Fall Time			29		ns
$E_{ON}$	Turn On Energy			1.73		mJ
$E_{OFF}$	Turn Off Energy			0.80		mJ
$E_{TOTAL}$	Total Switching Energy			2.53		mJ

**Diode Characteristics** (  $T_{VJ} = 150^\circ\text{C}$  )

$T_{RR}$	Reverse Recovery Time	$V_R = 400\text{ V}, I_F = 75\text{ A},$ $di/dt = 1300\text{ A}/\mu\text{s}$		114		ns
$Q_{RR}$	Reverse Recovery Charge			5.5		$\mu\text{C}$
$I_{RRM}$	Peak Reverse Recovery Current			58		A
$d_{irr}/dt$	Diode Peak Rate of Fall of Reverse Recovery Current			1900		$\text{A}/\mu\text{s}$

$T_{RR}$	Reverse Recovery Time	$V_R = 400\text{ V}, I_F = 37.5\text{ A},$ $di/dt = 1250\text{ A}/\mu\text{s}$		175		ns
$Q_{RR}$	Reverse Recovery Charge			3.7		$\mu\text{C}$
$I_{RRM}$	Peak Reverse Recovery Current			55		A
$d_{irr}/dt$	Diode Peak Rate of Fall of Reverse Recovery Current			2382		$\text{A}/\mu\text{s}$

# Electrical Characteristics Diagrams

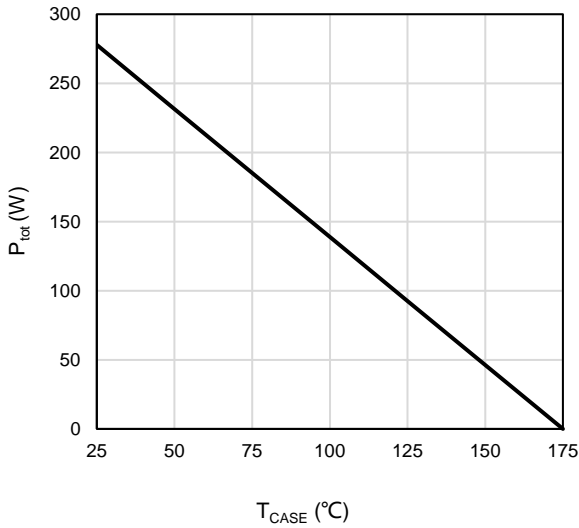


Figure 1: Power De-rating

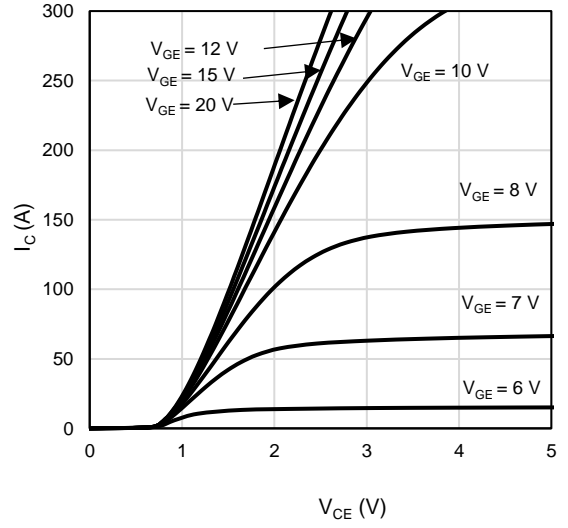


Figure 2: Typical Output Characteristics ( $T_{VJ}=25^{\circ}C$ )

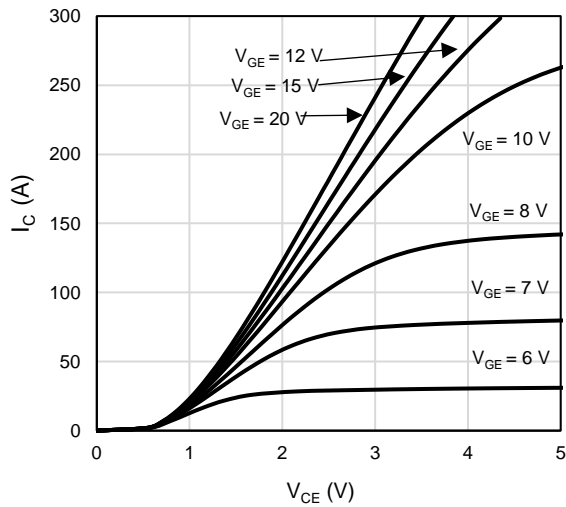


Figure 3: Typical Output Characteristics ( $T_{VJ}=150^{\circ}C$ )

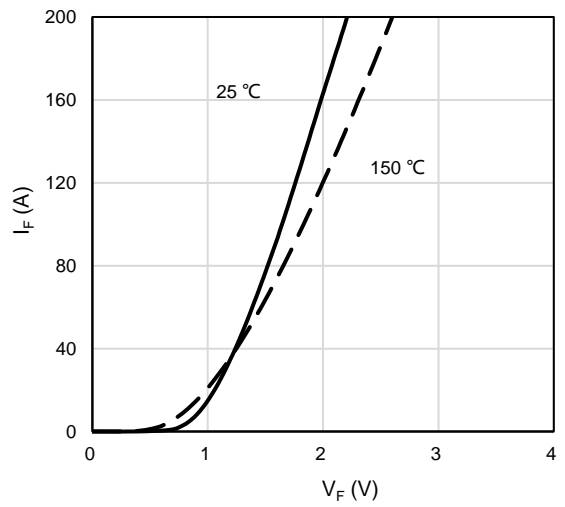


Figure 4: Diode Forward Current Characteristics

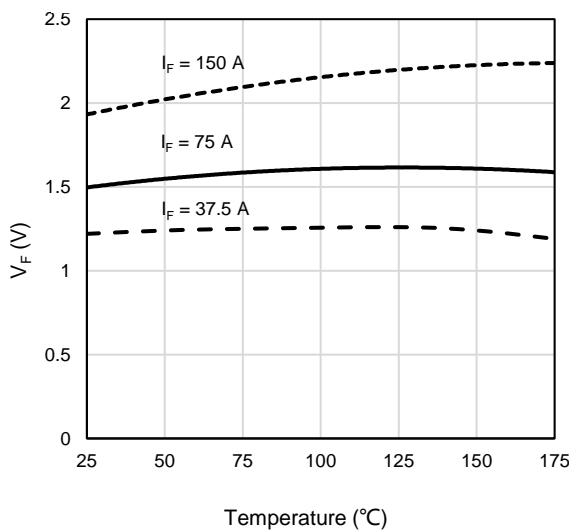


Figure 5: Diode Forward Voltage vs. Junction Temperature

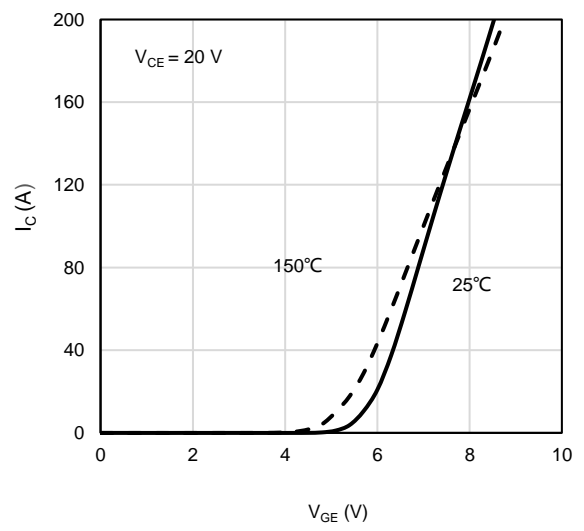


Figure 6: Transfer Characteristics

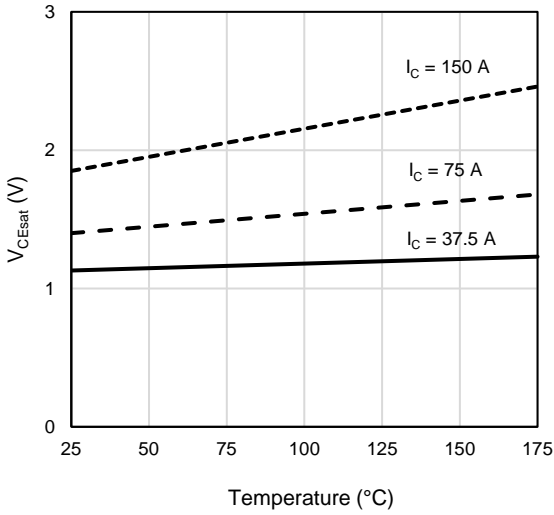


Figure 7: Collect-emitter saturation voltage vs. Junction Temperature

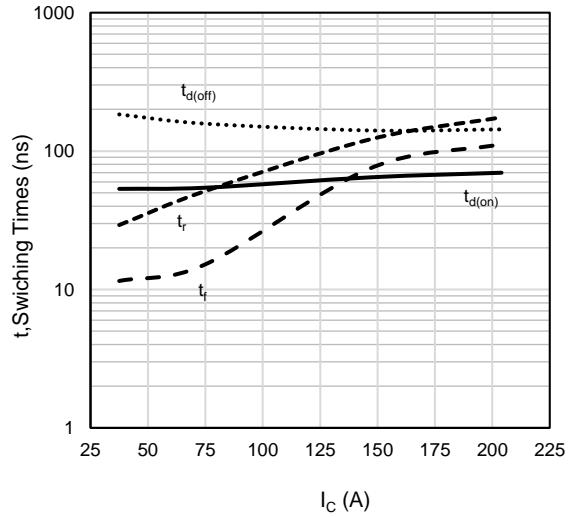


Figure 8: Switching Times vs. Collector Current

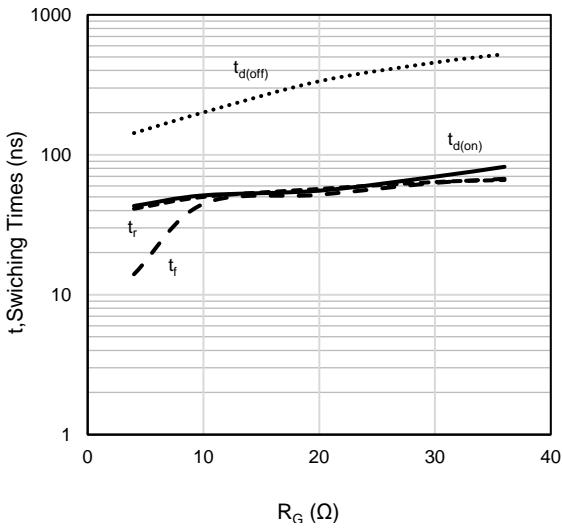


Figure 9: Switching Times vs. Gate Resistor

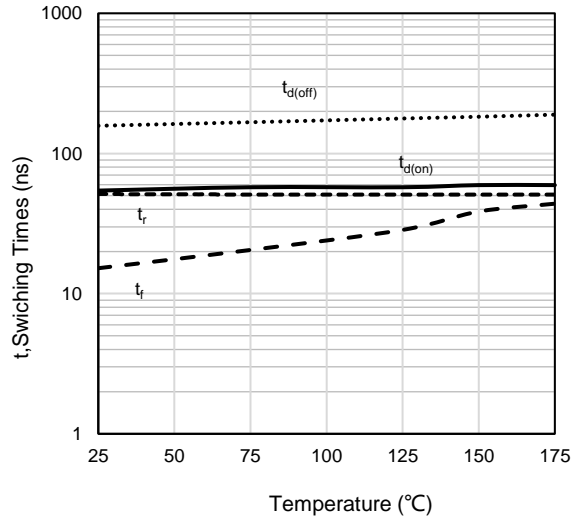


Figure 10: Switching Times vs. Junction Temperature

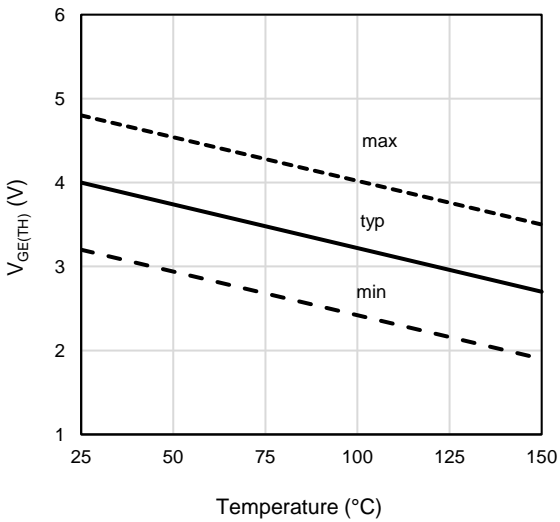


Figure 11: Threshold voltage vs. Junction Temperature

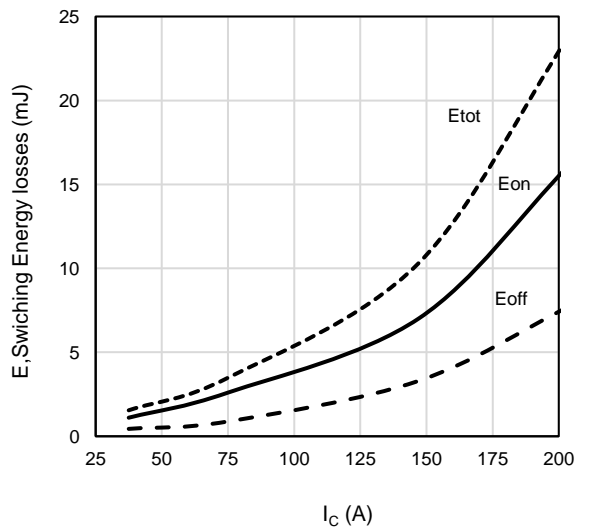


Figure 12: Switching Energy losses vs. Collector Current

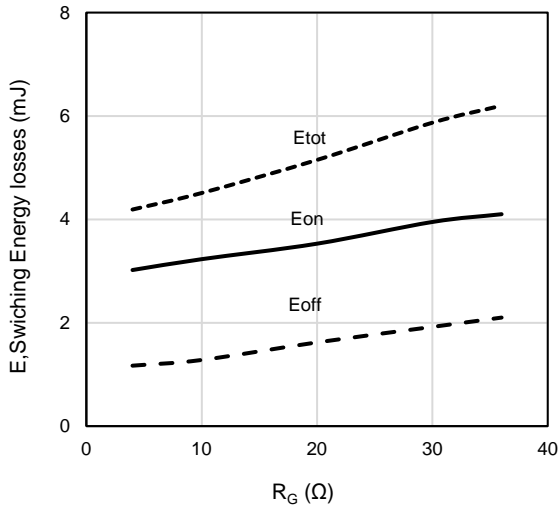


Figure 13: Switching Energy losses vs. Gate Resistor

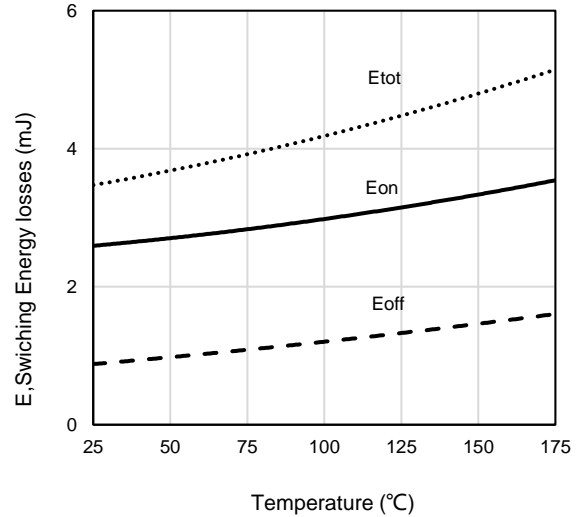


Figure 14: Switching Energy losses vs. Junction Temperature

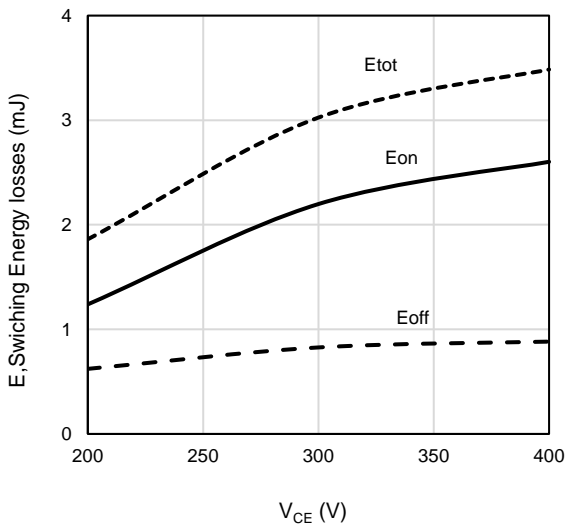


Figure 15: Switching Energy losses vs. Collector Emitter Voltage

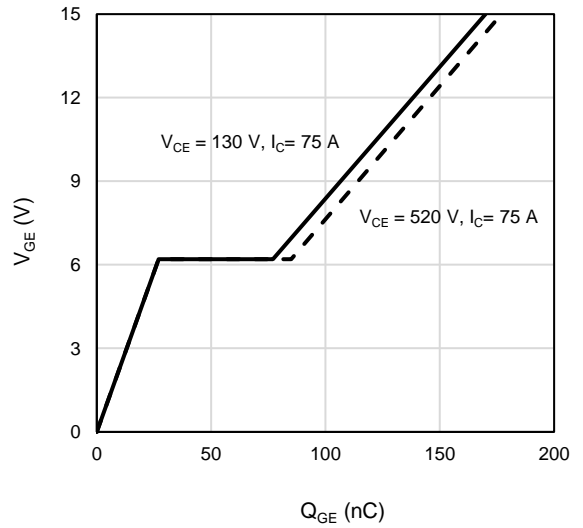


Figure 16: Gate-Charge Characteristics

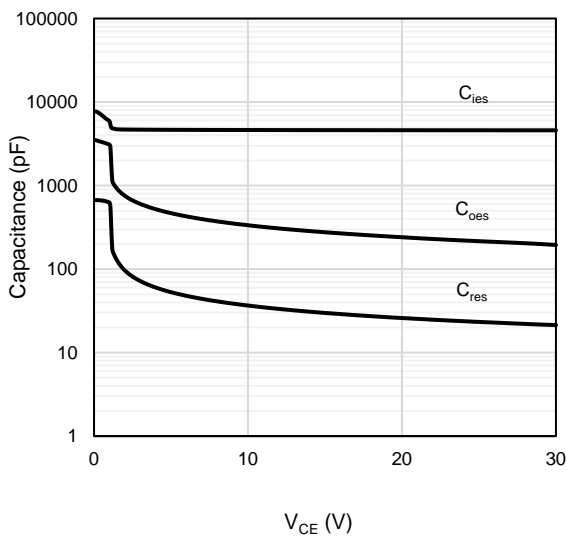


Figure 17: Capacitance Characteristics

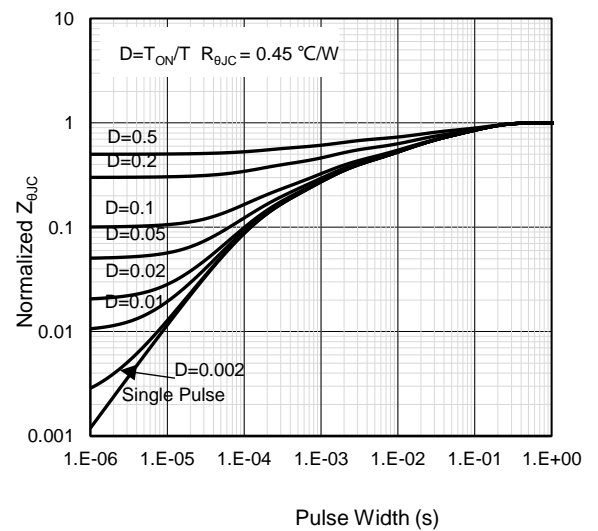


Figure 18: Normalized Maximum IGBT Transient Thermal Impedance



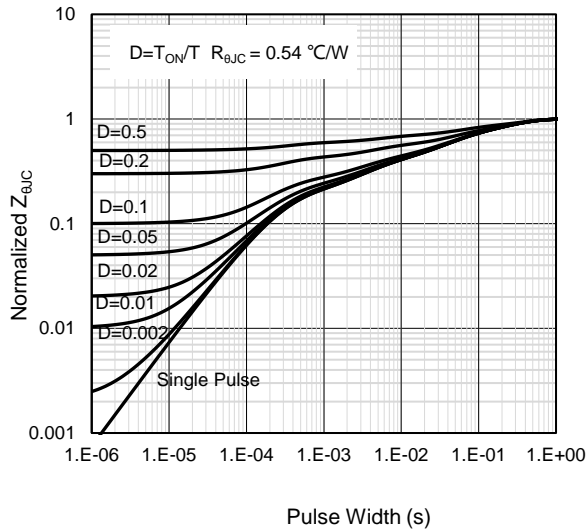


Figure 19: Normalized Maximum Diode Transient Thermal Impedance

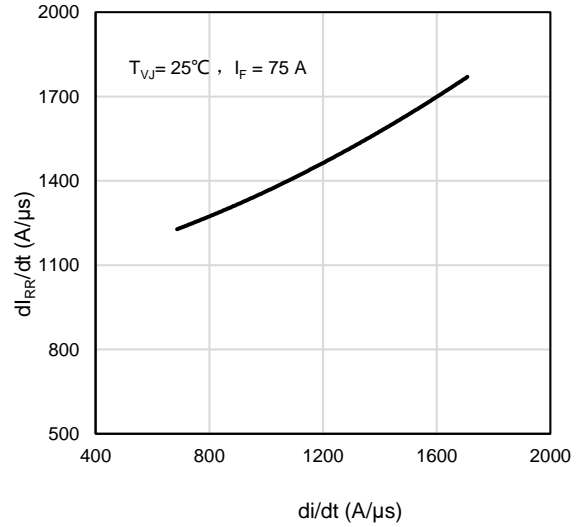


Figure 20: Diode Peak Rate of Fall of Reverse Recovery Current vs. Diode Current Slope

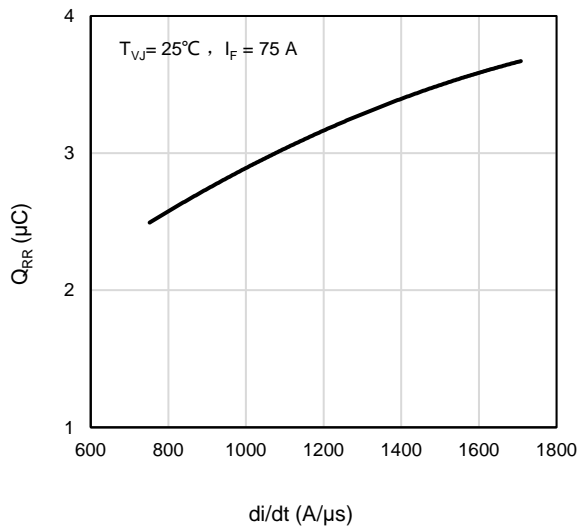


Figure 21: Reverse Recovery Charge vs. Diode Current Slope

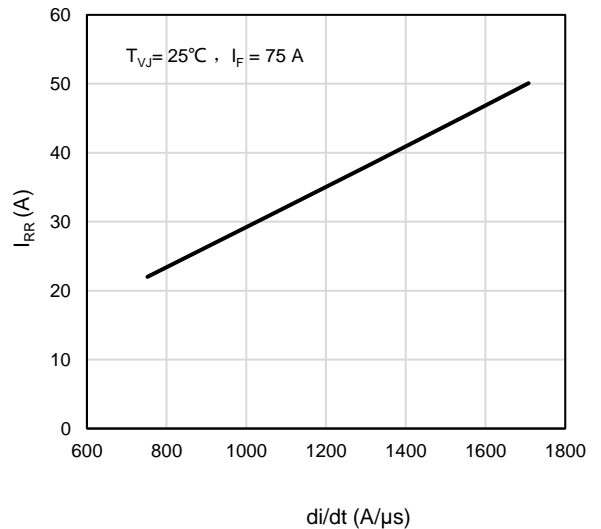


Figure 22: Reverse Recovery Current vs. Diode Current Slope

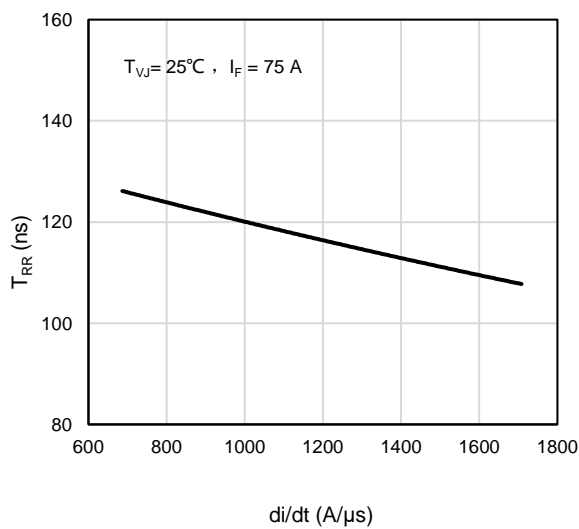
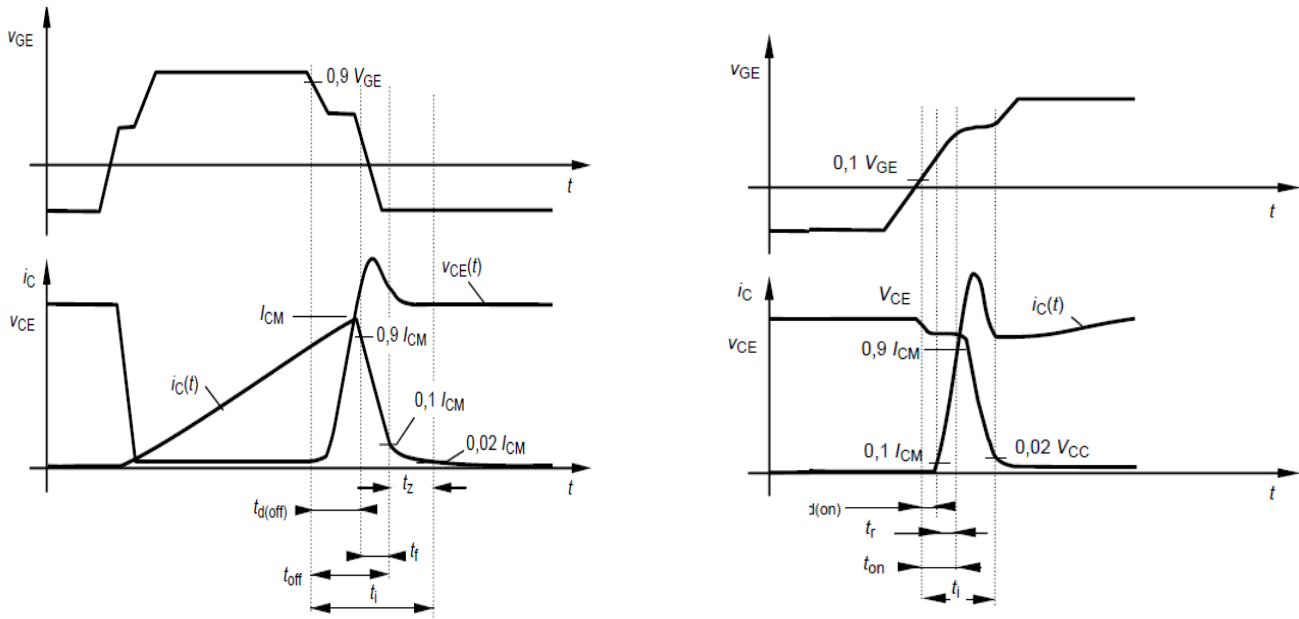


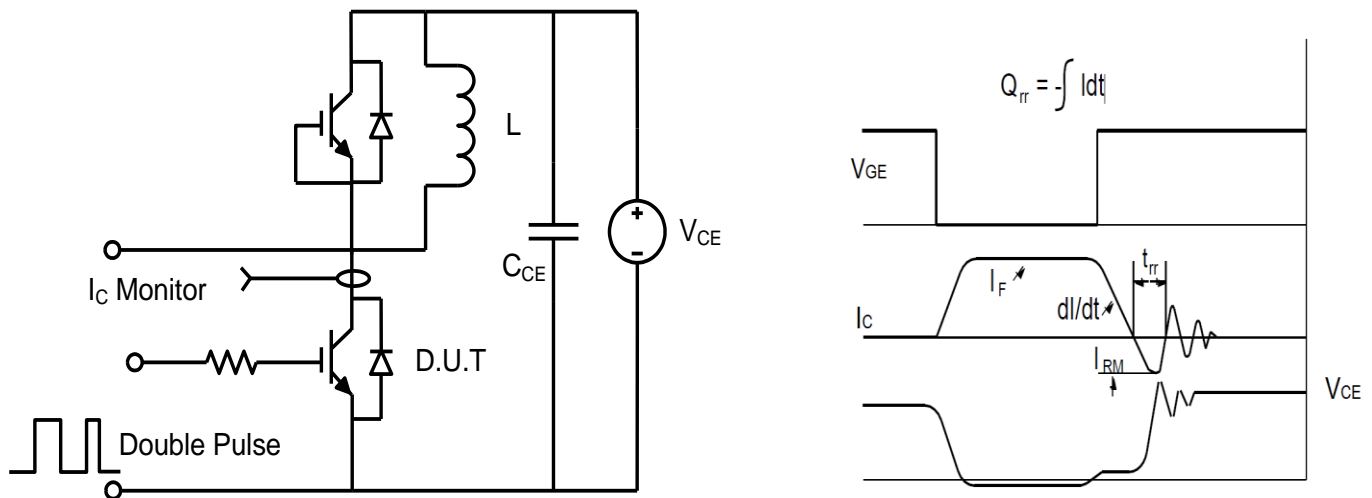
Figure 23: Reverse Recovery Time vs. Diode Current Slope

# Test Circuit and Waveform

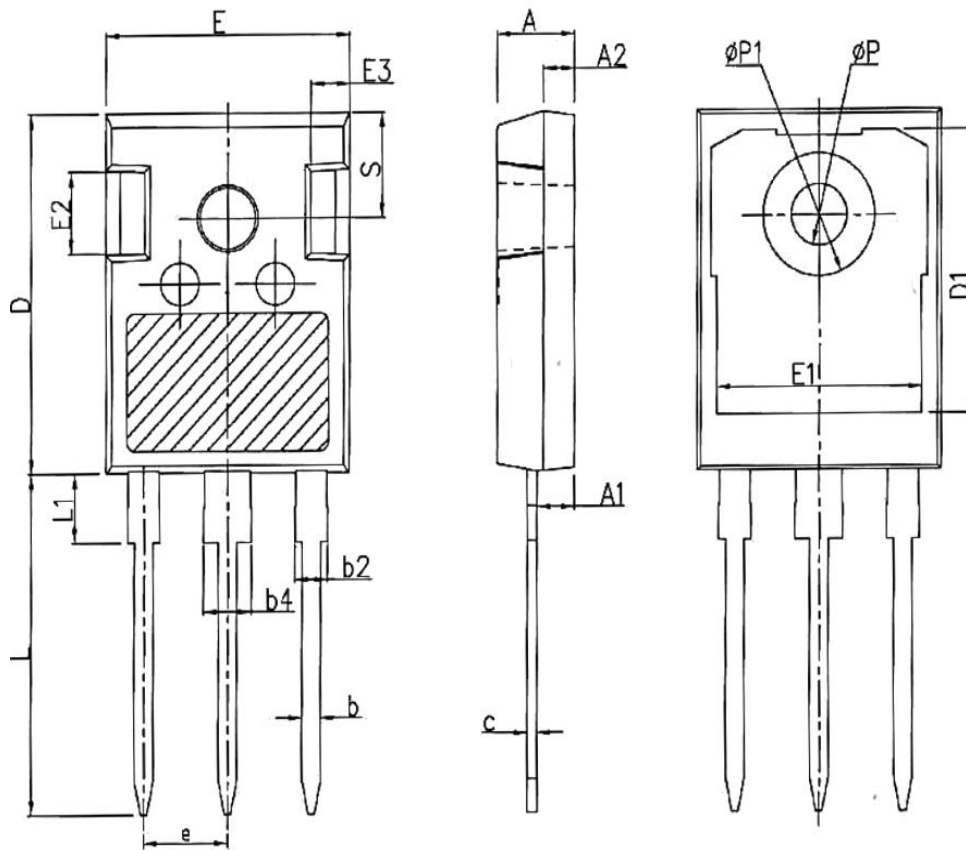
## Switching Test Circuit & Waveforms



## Diode Recovery Test Circuit & Waveforms



## Package Outlines



SYMBOL	mm		
	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.21	2.41	2.59
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b2	1.91	2.01	2.21
b4	2.91	3.01	3.21
c	0.51	0.61	0.75
D	20.70	21.00	21.30
D1	16.25	16.55	16.85
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.80	5.00	5.20
E3	2.30	2.50	2.70
e	5.44BSC		
L	19.62	19.92	20.22
L1	-	-	4.30
$\Phi P$	3.40	3.60	3.80
$\Phi P1$	-	-	7.30
S	6.15BSC		

## Marking Information



B65A075WHS

XXXXXXXX

Note:

B65A075WHS = Product Name Code

XXXXXXXX = Date code

Contact ALKAIDSEMI sales for detail information

## Revision History

Revision	Released	Remark
Rev.1.0	2023	Initial Release

## Disclaimer

The information given in this document describes the independent performance of the product, but similar performance is not guaranteed under other working conditions, and cannot be guaranteed when installed with other products or equipment. To achieve the required performance of the product in actual scenarios, the customer should conduct a complete application test to assess the functionality of the product.

Alkaidsemi assumes no responsibility for equipment failures result from using products at values that exceed the ratings, operating conditions, or other parameters listed in the product specifications.

The product described in this specification is not applicable for aerospace or other applications which requires high reliability. Customers using or selling these products for use in medical, life-saving, or life-sustaining applications do so at their own risk and agree to fully indemnify.

Due to product or technical improvements, the information described or contained herein may be changed without prior notice.